

Search Notes



Application/Control No.

10/017,500

Examiner

Hieu Phan

Applicant(s)/Patent under
Reexamination

SIRHAN ET AL.

Art Unit

3738

SEARCHED

Class	Subclass	Date	Examiner
update	search	09/27/05	GP
424	423	10/02/05	GP
435	395	10/02/05	GP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
424	423	10/02/05	GP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR